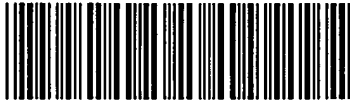


Search Notes

Application/Control No.

10/633,619

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

STELLBRINK ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	22,24,29 30,32,33 49,86,36	3/17/2005	<i>SWH</i> SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search (see attached)	3/15/2005	<i>SWH</i> SWH